

### General Description

It combines advanced trench MOSFET technology with a low resistance package to provide extremely low  $R_{DS(ON)}$ .

### Features

- Low  $R_{DS(ON)}$  to minimize conductive loss
- Low Gate Charge for fast switching
- Low Thermal resistance

### Application

- BLDC Motor driver
- DC-DC
- Battery protection

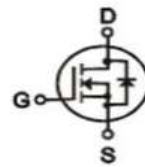
### Ordering Information:

|                           |            |
|---------------------------|------------|
| Part NO.                  | ZMS065N12B |
| Marking                   | ZMS065N12  |
| Packing Information       | REEL TAPE  |
| Basic ordering unit (pcs) | 800        |

### Absolute Maximum Ratings ( $T_C=25^\circ\text{C}$ )

| Parameter                         | Symbol    | Conditions                                                        | Min. | Max. | Unit             |
|-----------------------------------|-----------|-------------------------------------------------------------------|------|------|------------------|
| Drain-Source Voltage              | $V_{DS}$  |                                                                   | 120  |      | V                |
| Gate-Source Voltage <sup>①</sup>  | $V_{GS}$  |                                                                   | -20  | 20   | V                |
| Continuous Drain Current          | $I_D$     | $T_C=25^\circ\text{C}$                                            |      | 105  | A                |
|                                   | $I_D$     | $T_C=75^\circ\text{C}$                                            |      | 105  | A                |
|                                   | $I_D$     | $T_C=100^\circ\text{C}$                                           |      | 93   | A                |
| Pulsed Drain Current <sup>①</sup> | $I_{DM}$  | Pulsed; $t_p \leq 10 \mu\text{s}$ ; $T_{mb} = 25^\circ\text{C}$ ; |      | 420  | A                |
| Total Power Dissipation           | $P_D$     | $T_C=25^\circ\text{C}$                                            |      | 156  | W                |
| Total Power Dissipation           | $P_D$     | $T_A=25^\circ\text{C}$                                            |      | 3.1  | W                |
| Operating Junction Temperature    | $T_J$     |                                                                   | -55  | 150  | $^\circ\text{C}$ |
| Storage Temperature               | $T_{STG}$ |                                                                   | -55  | 150  | $^\circ\text{C}$ |
| Single Pulse Avalanche Energy     | $E_{AS}$  | $L=0.1\text{mH}$ , $V_{GS}=10\text{V}$ , $R_g=25\Omega$ ,         |      | 180  | mJ               |
| ESD Level (HBM)                   |           | CLASS 2                                                           |      |      |                  |

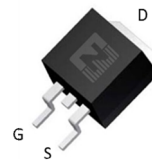
### Product Summary



$$V_{DS} = 120\text{V}$$

$$R_{DS(ON)} = 6.5\text{m}\Omega$$

$$I_D = 105\text{A}$$



TO-263



**•Thermal resistance**

| Parameter                            | Symbol             | Min. | Typ. | Max. | Unit |
|--------------------------------------|--------------------|------|------|------|------|
| Thermal resistance, junction - case  | RthJC              |      | -    | 0.8  | °C/W |
| Thermal resistance, junction-ambient | RthJA <sup>②</sup> |      | -    | 40   | °C/W |
| Soldering temperature                | Tsold              |      | -    | 260  | °C   |

**•Electronic Characteristics**

| Parameter                         | Symbol              | Condition                                                  | Min. | Typ. | Max. | Unit |
|-----------------------------------|---------------------|------------------------------------------------------------|------|------|------|------|
| Drain-Source Breakdown Voltage    | BV <sub>DSS</sub>   | V <sub>GS</sub> = 0V, I <sub>D</sub> = 250uA               | 120  |      |      | V    |
| Gate Threshold Voltage            | V <sub>GS(TH)</sub> | V <sub>GS</sub> = V <sub>DS</sub> , I <sub>D</sub> = 250uA | 1.3  | 1.8  | 2.5  | V    |
| Drain-Source Leakage Current      | I <sub>DSS</sub>    | V <sub>GS</sub> = 0V, V <sub>DS</sub> = 120V               |      |      | 1    | uA   |
| Gate- Source Leakage Current      | I <sub>GSS</sub>    | V <sub>GS</sub> = ±20V, V <sub>DS</sub> = 0V               |      |      | 100  | nA   |
| Static Drain-source On Resistance | R <sub>DS(ON)</sub> | V <sub>GS</sub> = 10V, I <sub>D</sub> = 25A                |      | 6.5  | 8.5  | mΩ   |
| Static Drain-source On Resistance | R <sub>DS(ON)</sub> | V <sub>GS</sub> = 4.5V, I <sub>D</sub> = 20A               |      | 8.2  | 12   | mΩ   |
| Forward Transconductance          | g <sub>FS</sub>     | V <sub>GS</sub> = 5V, I <sub>SD</sub> = 10A                |      | 50   |      | s    |
| Diode Forward Voltage             | V <sub>FSD</sub>    | V <sub>GS</sub> = 0V, I <sub>SD</sub> = 25A                |      |      | 1.3  | V    |

**•Dynamic characteristics**

| Parameter                    | Symbol              | Condition                                                                                    | Min. | Typ. | Max. | Unit |
|------------------------------|---------------------|----------------------------------------------------------------------------------------------|------|------|------|------|
| Input capacitance            | Ciss                | f = 1MHz, V <sub>DS</sub> = 25V                                                              | -    | 3750 | -    | pF   |
| Output capacitance           | Coss                |                                                                                              | -    | 1830 | -    |      |
| Reverse transfer capacitance | Crss                |                                                                                              | -    | 190  | -    |      |
| Gate Resistance              | Rg                  | f = 1MHz                                                                                     | -    | 1.6  |      | Ω    |
| Total gate charge            | Qg                  | V <sub>DD</sub> = 15V,<br>I <sub>D</sub> = 25A,<br>V <sub>GS</sub> = 10V                     | -    | 57   | -    | nC   |
| Gate - Source charge         | Qgs                 |                                                                                              | -    | 8.8  | -    |      |
| Gate - Drain charge          | Qgd                 |                                                                                              | -    | 10.7 | -    |      |
| Turn-ON Delay time           | t <sub>D(on)</sub>  | V <sub>GS</sub> = 10V, V <sub>DS</sub> = 15V,<br>R <sub>G</sub> = 3.3Ω, I <sub>D</sub> = 20A | -    | 15   | -    | ns   |
| Turn-ON Rise time            | t <sub>r</sub>      |                                                                                              | -    | 10   | -    | ns   |
| Turn-Off Delay time          | t <sub>D(off)</sub> |                                                                                              | -    | 43   | -    | ns   |
| Turn-Off Fall time           | t <sub>f</sub>      |                                                                                              | -    | 12   | -    | ns   |
| Reverse Recovery Time        | t <sub>RR</sub>     | V <sub>DD</sub> = 20V, dI <sub>S</sub> /dt =<br>100A/s, I <sub>S</sub> = 50A                 | -    | 80   | -    | ns   |
| Reverse Recovery Charge      | Q <sub>RR</sub>     |                                                                                              | -    | 185  | -    | nC   |

Fig.1 Gate-Charge Characteristics

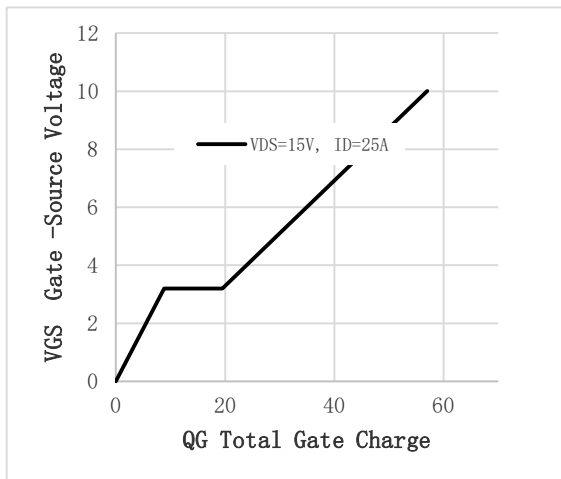


Fig.2 Capacitance Characteristics

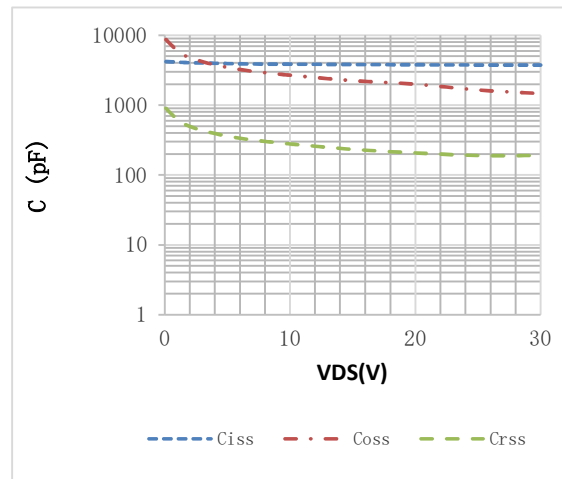


Fig.3 Power Dissipation

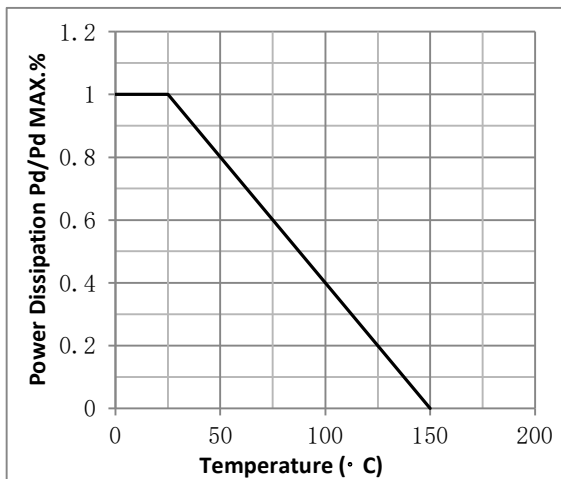


Fig.4 Typical output Characteristics

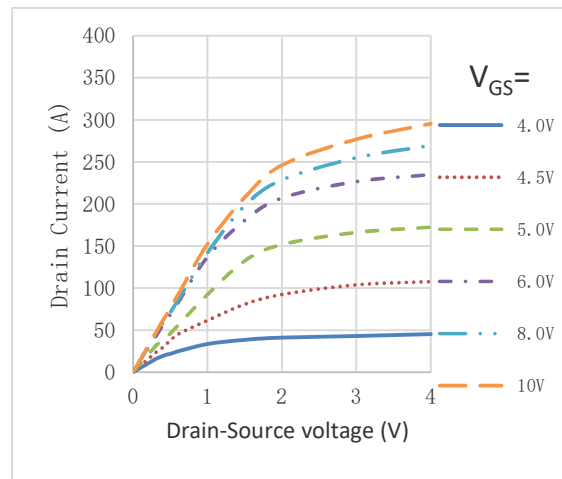


Fig.5 Threshold Voltage V.S Junction Temperature

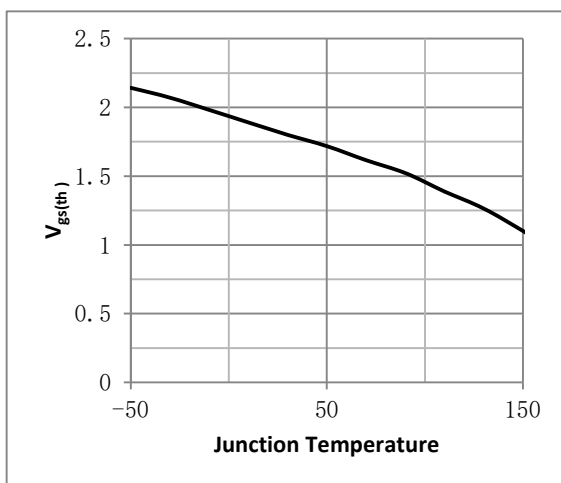


Fig.6 Resistance V.S Drain Current

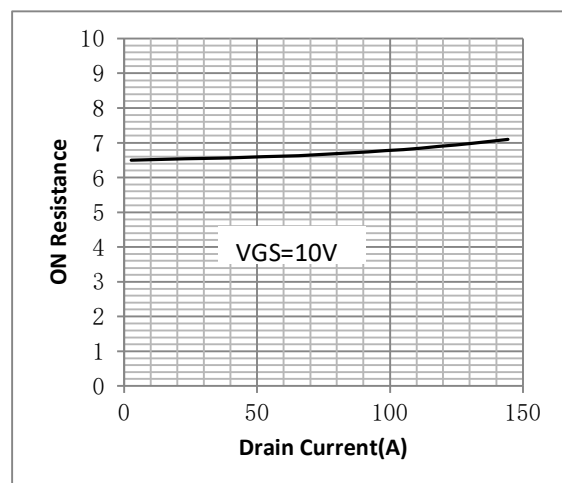


Fig.7 On-Resistance VS Gate Source Voltage

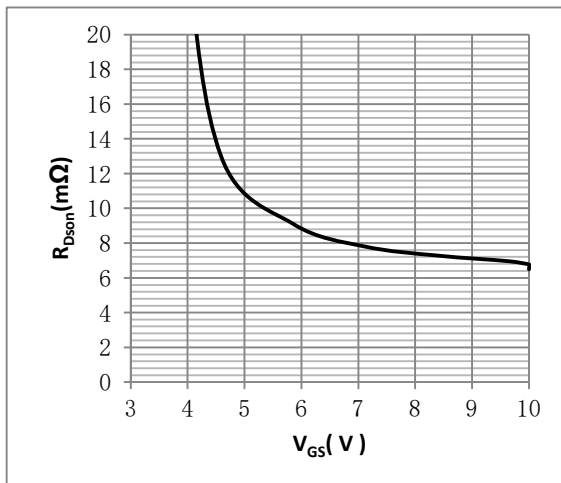


Fig.8 On-Resistance V.S Junction Temperature

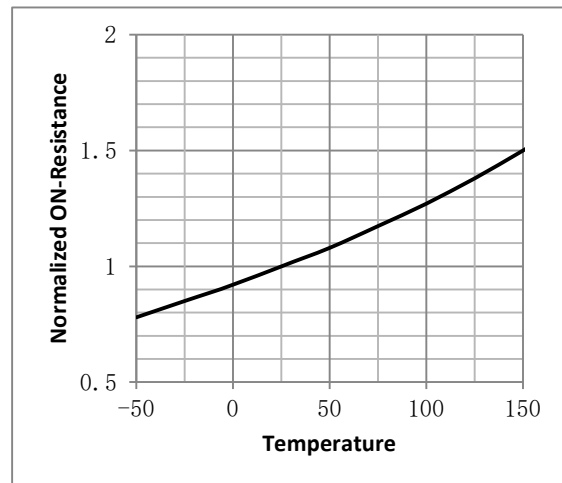


Figure 9. Diode Forward Voltage vs. Current

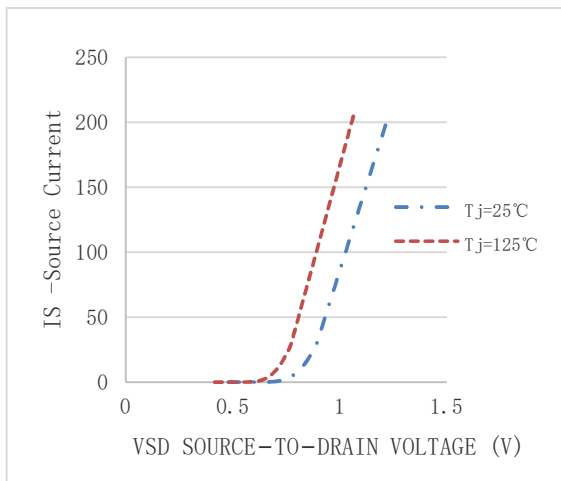


Figure 10. Transfer Characteristics

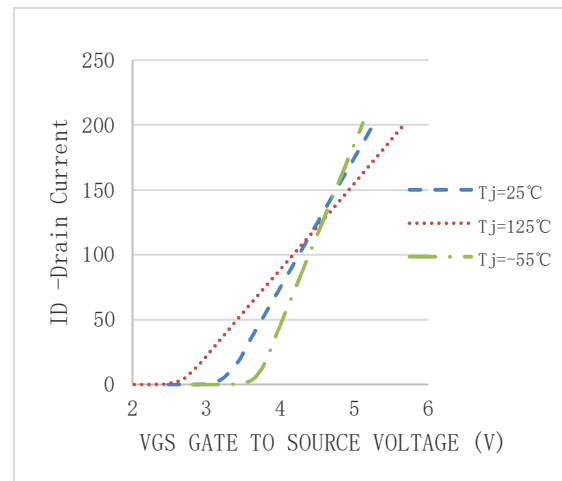


Fig.11 SOA Maximum Safe Operating Area

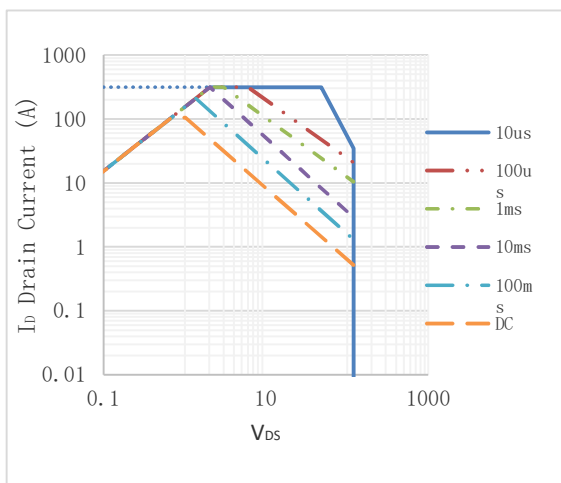
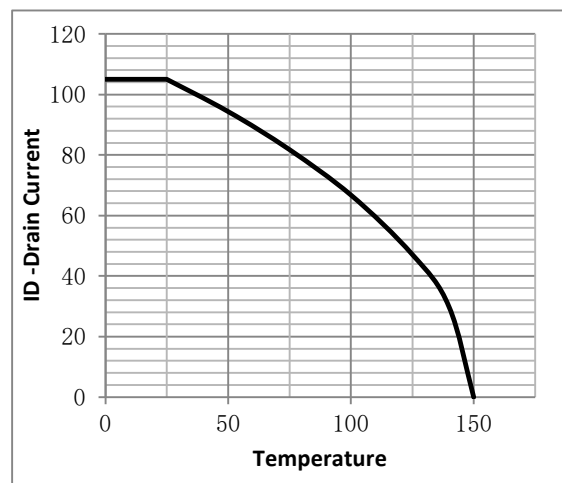


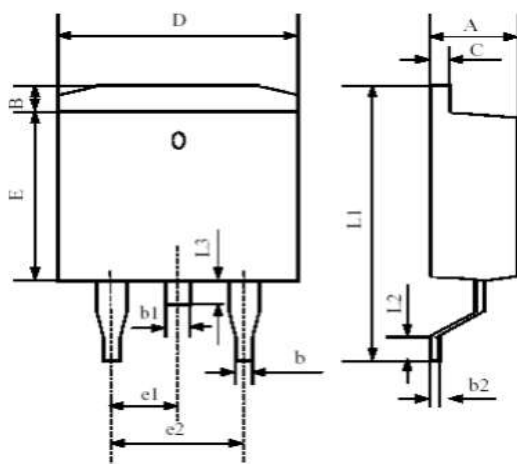
Fig.12  $I_D$  vs. Junction Temperature



•TO-263 Package Outline

Unit: mm

| SYMBOL | MIN  | TYP | MAX   | SYMBOL | MIN   | TYP | MAX   |
|--------|------|-----|-------|--------|-------|-----|-------|
| A      | 4.42 |     | 4.72  | E      | 8.99  |     | 9.29  |
| B      | 1.22 |     | 1.32  | e1     | 2.44  |     | 2.64  |
| b      | 0.76 |     | 0.86  | e2     | 4.98  |     | 5.18  |
| b1     | 1.22 |     | 1.32  | L1     | 15.19 |     | 15.79 |
| b2     | 0.33 |     | 0.43  | L2     | 2.29  |     | 2.79  |
| C      | 1.22 |     | 1.32  | L3     | 1.3   |     | 1.75  |
| D      | 9.95 |     | 10.25 |        |       |     |       |



**Note:**

- ① Pulse Test: Pulse width  $\leq 300\mu\text{s}$ , Duty cycle  $\leq 2\%$ , Accumulation time  $\leq 50$  hours; For DC , the following test conditions can be passed:  $V_{GS}=+20V/-10V$ ,  $T_j=150^{\circ}\text{C}$ ,  $t=1000$  hours;
- ② Device mounted on FR-4 substrate PC board, 2oz copper, with thermal bias to bottom layer 1inch square copper plate;

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